The product described herein has not been fully tested to ensure conformance to the requirements outlined below. TE Connectivity makes no representation or warranty, express or implied, that the product will comply with these requirements. Further, TE may change these requirements based on the results of additional testing and evaluation. Contact TE Engineering for further details. Design Objective (108-115183) **1.5mm Pitch Single Row WTB with Latch** 1. Scope: 1.1 Contents: This specification covers the requirements for product performance, test methods and quality assurance provisions of 1.5mm Pitch Wire to Board Connector with Latch Applicable product description and part numbers are as shown in Fig.1. 2. Applicable Documents The following documents form a part of this specification to the extent specified herein. In the event of conflict between the requirements this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements this specification and referenced documents, this specification shall take precedence. 2.1 AMP Specifications: A. 109-5000 Test Specification, General Requirements for Test Methods B. 501-115198 Test Report 2.2 Commercial Standards and Specifications: A. EIA-364: Test Methods for Electronic and Electrical Component Parts. (Always use latest version for test) The application product descriptions and part numbers are as shown in Fig. 1 Product Part No. Description x-2380312-x Cable Housing of 1.5mm Pitch Wire to Board Connector with Latch 2380403-x Cable Contact of 1.5mm Pitch Wire to Board Connector with Latch x-2380320-x Vertical Type Board Side of 1.5mm Pitch Wire to Board Connector with Latch x-2381626-x Right Angle Type Board Side of 1.5mm Pitch Wire to Board Connector with Latch Fig. 1 (End) Tommy Qian 1st April' 19 **TE Connectivity** CHK Wenke He 1st April' 19 APP Wenke He 1st April' 19 REV LOC NO 108-115183 ES A TITLE 1ST Dec PAGE Α T.Q INITIAL RELEASED 20 1.5mm Pitch Wire to Board Connector 1 of 6 LTR REVISION RECORD DR DATE

3. Requirement	s:
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3.1 Design and Construction:

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

3.2 Materials:

A. Board side:

Contacts:	Gold plating or Tin plating, Copper Alloy
Housing:	LCP, UL94V-0, Natural or Black
Metal Peg:	Tin plating, Copper Alloy

B. Cable side:

Contacts:	Gold plating or Tin plating, Copper Alloy
Housing:	Nylon, UL94V-0, Natural or Black

3.3 Ratings:

- A. Voltage Rating: 50 Volts AC (per pin)
- B. Current Rating (Maximum)
 - AWG # 24: 3.0 A (per pin) *
 - AWG # 26: 3.0 A (per pin)
 - AWG #28: 2.5 A (per pin)
 - AWG # 30: 1.5 A (per pin)

*The current rating was loaded in parallel by all pins for 15pos parts.

C. Temperature Rating: -40° C to $+105^{\circ}$ C

The upper limit of the temperature includes the temperature rising resulted by the energized electrical current.

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3.4 Performance Requirements and Test Descriptions:

The product shall be designed to meet the electrical, mechanical and environmental performance requirements specified in Fig.2. All tests shall be performed in the room temperature unless otherwise specified.

3.5	Test Requirements	and Procedures	Summary
3.5	Test Requirements	and Procedures	Summary

Para.	Test Items	Requirements	Procedures
3.6.1	Examination of product	Product shall be confirming to the requirements of applicable product drawing and applicable Specification	Visual and Dimensional Inspection Test Procedure for Electrical Connectors. EIA-364-18
Electr	ical Requirements		
3.6.2	Termination Resistance (Low Level)	20 mΩ Max. (Initial) $\Delta R < 10 mΩ$ (Final)	Subject mated contacts assembled in housing to 20mV Max. open circuit at 10 mA. EIA-364-23
3.6.3	Dielectric withstanding voltage	No creeping discharge or flashover shall occur. Current leakage: 1mA Max.	500 VAC Min. at sea level for 1 minute Test between adjacent contacts of unmated connectors. (EIA-364-20)
3.6.4	Insulation Resistance	1000 MΩ Min	Unmated connectors, apply 500 V DC between adjacent terminals. (EIA-364-21)
3.6.5	Temperature Rising	30°C max, when apply current rate	Mate connector: measure the temperature rise at rated current until temperature stable. The ambient condition is still air at 25°C (EIA-364-70 METHOD 2)
		Fig.2. To be continued	1

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Mechanic 3.6.6		Requirements	Procedures					
3.6.6	cal Requirements	I						
	Connector	See item 5	Operation Speed :					
	Mating/Unmating		25.4 ± 3 mm/minute					
			Measure the force required to mate/unmated connector.					
			Unmated connector angle θ is +/-20 degree max. See figure 1					
			(EIA-364-13)					
3.6.7	Durability (Repeated Mate/Unmating)	30 cycles	The sample should be mounted in the tester and fully mated and unmated the number of cycles specified at the rate of					
			25.4 ± 3 mm/min.					
			(EIA-364-09)					
3.6.8	Vibration (Low Frequency)	1 us Max.	The electrical load condition shall be 100 mA maximum for all contacts. Subject to a simple harmonic motion having amplitude of 0.76mm (1.52mm maximum total excursion) in frequency between the limits of 10 and 55 Hz. The entire frequency range, from 10 to 55 Hz and return to 10 Hz, shall be traversed in approximately 1 minute. This motion shall be applied for 2 hours in each of three mutually perpendicular directions.					
			(EIA-364-28 Condition I)					
3.6.9	Physical Shock	1 us Max.	Subject mated connectors to 50 G's (peak value) half-sine shock pulses of 11 milliseconds duration. Three shocks in each direction shall be applied along the three mutually perpendicular axes of the test specimen (18 shocks). The electrical load condition shall be 100mA maximum for all contacts. (EIA-364-27, test condition A)					
3.6.10	Contact Retention	0.50 kgf Min.	Operation Speed :					
	Force of Doard Side		25.4 ± 3 mm/minute.					
			Measure the contact retention force with Tensile strength tester.					

3.6.11	crimping Terminal Pull Strength of the housing (Cable size)	0.50 kgf Min.	Operation Speed : 25.4 ± 3 mm/minute. Measure the Terminal retention force with Tensile strength tester.
3.6.12	Wire Crimping Strength	AWG# 24: 2.0Kgf Min AWG# 26: 1.5Kgf Min AWG# 28: 1.0Kgf Min AWG# 30: 0.5Kgf Min.	Pull wire axially from at the speed rate of 25.4 ± 3 mm/min.

Fig. 2 (To be continued)

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Para	Test Items	Requirements		Procedures						
Enviro	nmental Requiren	nents								
3.6.11	Thermal Shock	See Product Qualifie Test Sequence Grou	cation and p 4	Mate module and subject to follow condition for 5 cycles.						
				1 cycles:						
				-40 +0/-3 °C, 30 minutes						
				+85 +3/-0 °C, 30 minutes						
				(EIA-364-32, test condition A)						
3.6.12	Humidity	See Product Qualifie	cation and	Mated Connector						
		Test Sequence Grou	p 4	40°C, 90~95% RH,						
				96 hours.						
				(EIA-364-31,Condition A, Method I	I)					
3.6.13	Salt Spray (Onl GOLD)	y for See Product Qualifie Test Sequence Grou	cation and	Subject mated/unmated connectors to salt-solution concentration, 35°C for hours.	o 5% · 24					
			•	(EIA-364-26,Test condition B)						
3.6.14	Temperature Li (Heat Aging)	fe See Product Qualifie	cation and	Subject mated connectors to tempera life at 85°C for 96 hours.	ature					
		Test Sequence Grou	p 5	(EIA-364-17, Test condition A)	(EIA-364-17, Test condition A)					
3.6.15	Solderability	Solder able area sha minimum of 95% so coverage.	ll have lder	Subject the test area of contacts into flux for 5-10 sec. And then into sold bath, Temperature at 245 ±5°C, for 4 sec. (EIA-364-52)	the er 4-5					
3.6.16				Pre Heat : 150°C~180°C, 60~120sec	c.	_				
	Peristance to P	See Product Qualifie	cation and	Heat : 230°C Min., 40sec Min.						
	Soldering Heat	Test Sequence Grou	p 6 (Lead	Peak Temp · 260°CMax						
		rice)		10sec Max						
		Fig.	2 (End)							
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					Te	st Gro	oup					
Test or Examination	1	2	3	4	5	6	7	8	9	10	11	1
					Test	t Sequ	ence					
Examination of Product				1,7	1,6	1,4						1,
Low Level Contact Resistance		1,5	1,4	2,10	2,9	2,5						2,
Insulation Resistance				3,9	3,8							
Dielectric Withstanding Voltage				4,8	4,7							
Temperature rise	1											
Mating / Unmating Forces		2,4										
Durability		3										
Contact Retention Force (Board								1				
Vibration			2									
Shock (Mechanical)			3									
Thermal Shock				5								
Humidity				6								
Temperature life					5							
Salt Spray												3
Crimping Terminal Pull Strength of									1			
the housing (Cable size)												
Board Lock Pull Strength of Wire Lock										1		
Wire Crimping Strength											1	
Solder ability							1					
Resistance to Soldering Heat						3						
Numbers indicate sequence in whic	ch th	e tests a	are per	forme	d.	I						
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4. PRODUCT QUALIFICATION AND TEST SEQUENCE

5. Mating / Unmating Force:

	Unit: N					
	At i	At 30th				
Pos. No. 2 3 4 5 6 7 8 9	Mating Force. (Max)	Unmating Force (Min)	Unmating Force (Min)			
2	20	2	2			
3	20	2	2			
4	20	2	2			
5	30	3	3			
6	30	3	3			
7	30	3	3			
8	40	4	4			
9	40	4	4			
10	40	4	4			
11	50	5	5			

Table 5

6. INFRARED REFLOW CONDITION



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7. ANATOMY OF CRIMPING TERMINAL



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9. CRIMPING CONDITION

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CRIMPING CONDITION								
Part Number	Part Number Wire Specification		tion	Crimp Height (mm)		Crimp Width (mm)		
	UL Style	AWC Size	Insulation OD(mm)	Conductor	Insulation	Conductor	Insulation	
	(REF.)	AWG Size		А	В	W1	W2	
2380403-*	UL1061	24	1.10	0.52~0.58	1.57~1.63	0.90(Ref)	1.05 max.	
	UL1061	26	1.00	0.52~0.58	1.47~1.53	0.80(Ref.)	1.05 max.	
	UL1061	28	0.90	0.52~0.58	1.37~1.43	0.70(Ref.)	1.05 max.	
	UL1061	30	0.70	0.52~0.58	1.25~1.31	0.60(Ref.)	1.05 max.	





Note:

- 1 W1: Conductor Crimping Width
- 2 · W2: Insulation Crimping Width
- 3 · A: Conductor Crimping height
- 4 . B: Insulation Crimping height
- 5 Strip length : 1.2~1.6mm

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11. PULL FORCE OF CRIMPING SECTION MEASUREMENT







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14 CRIMPING REQUIREMENTS



Item	Range(Ref.)
Max. Up Bend	6°
Max. Down Bend	6°
Max. Left Twist	5°
Max. Right Twist	5°
Bell-Mouth Length	0.1~0.3mm
Carrier Cut Off Length	0~0.2mm
Conductor Extruded Length	0.1~0.3mm

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